

Search Notes

Application/Control No.

10/617,151

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

GOODIN ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	302	9/2005	jsc
430	165		
430	207.1		
430	273.1		
101	456		
101	46.1		
101	465		
101	466		
101	467		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH UPDATED	9/2005	jsc